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| Notice of References Cited | Application/Control No. 09/993,930 | Applicant(s)/Patent Under Reexamination FLICK, KENNETH E. | |
| | Examiner Matsuichiro Shimizu | Art Unit 2635 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-5,815,084 | 09-1998 | Lavelle et al. | 340/5.22 |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
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| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
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FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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| | Q | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
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| | V | |
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